

Supporting Information

Multiple effect of Bi doping to enhanced thermoelectric properties of SnTe

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1. Rietveld refinements

The PXRD patterns of $\text{Sn}_{1-x}\text{Bi}_x\text{Te}$ ($x=0, 0.02, 0.04, 0.06, 0.08$) have been refined by the GSAS with EXPGUI interface.²⁷⁻²⁸

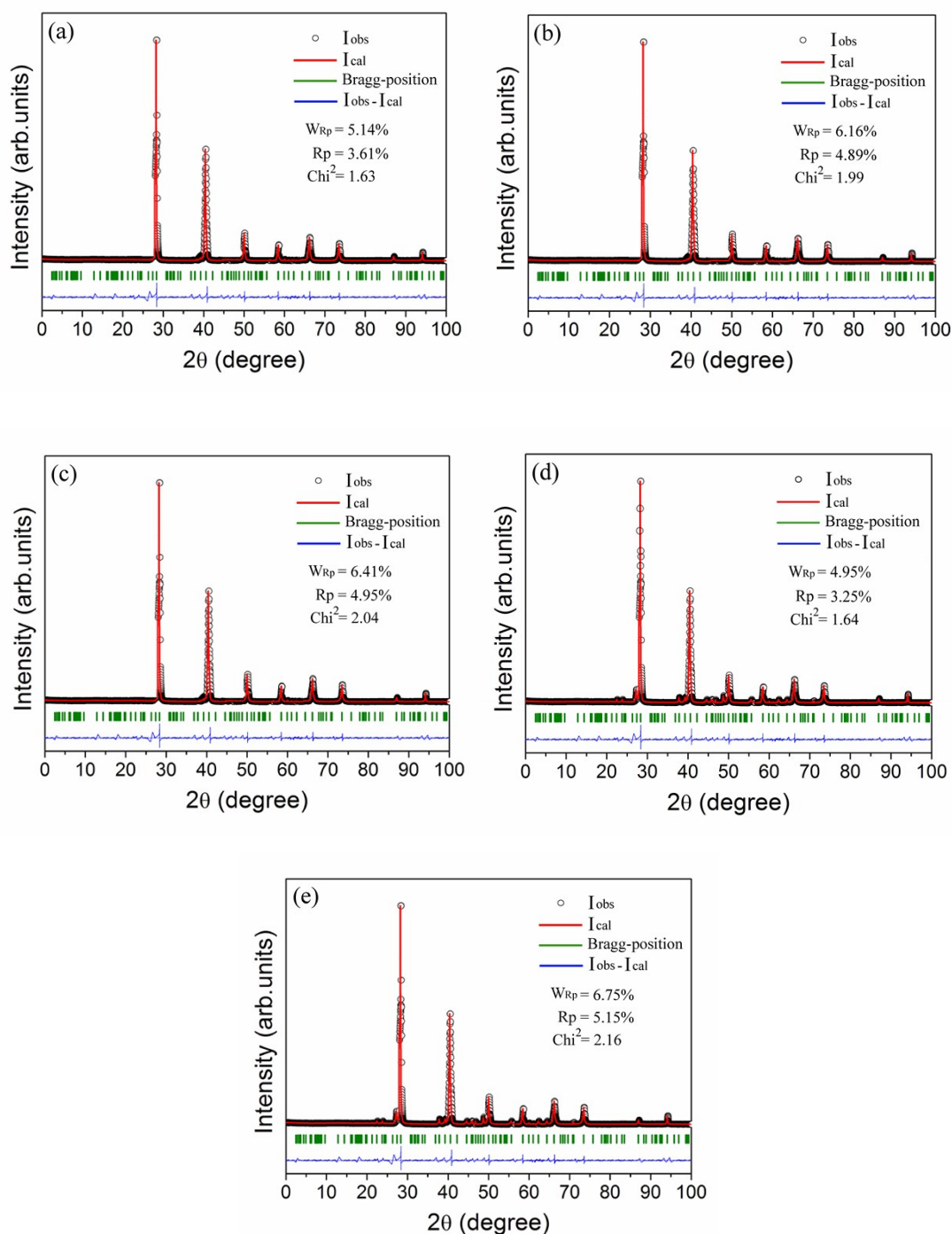


Fig. S1 Rietveld refinements of $\text{Sn}_{1-x}\text{Bi}_x\text{Te}$ ($x=0, 0.02, 0.04, 0.06, 0.08$).

2. Elemental mapping

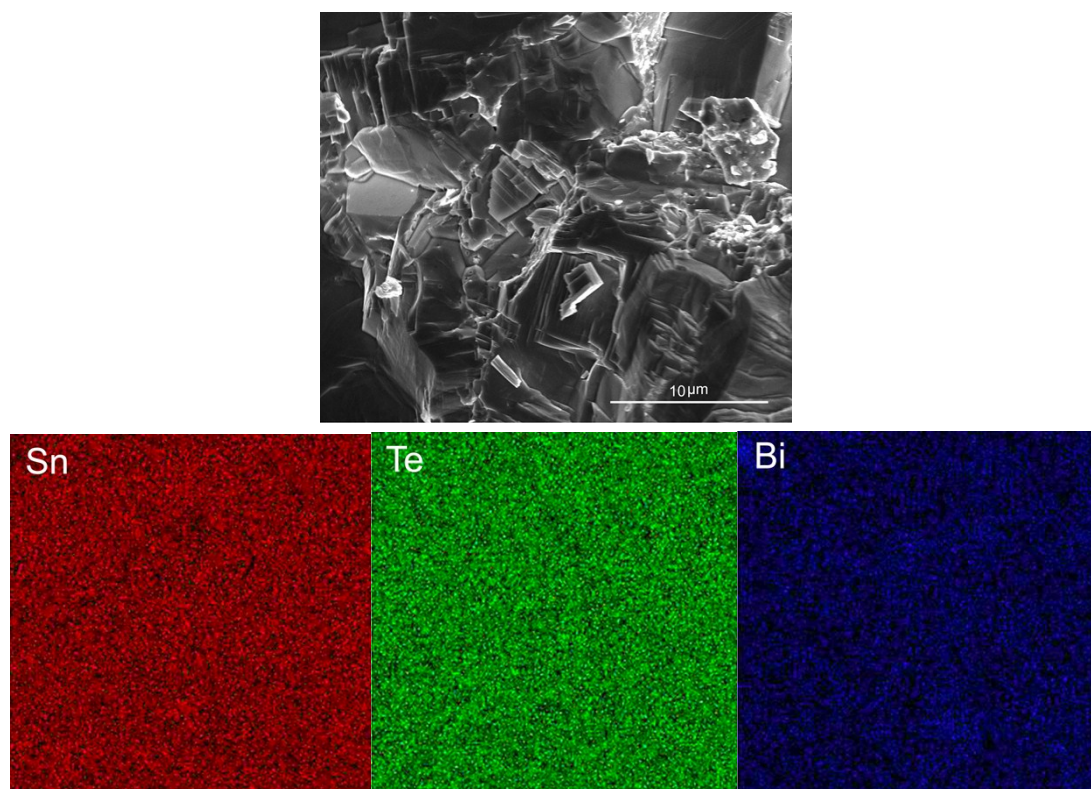


Fig. S2 The elemental mapping of $\text{Sn}_{0.94}\text{Bi}_{0.06}\text{Te}$.

3. Specific heat capacity (C_p)

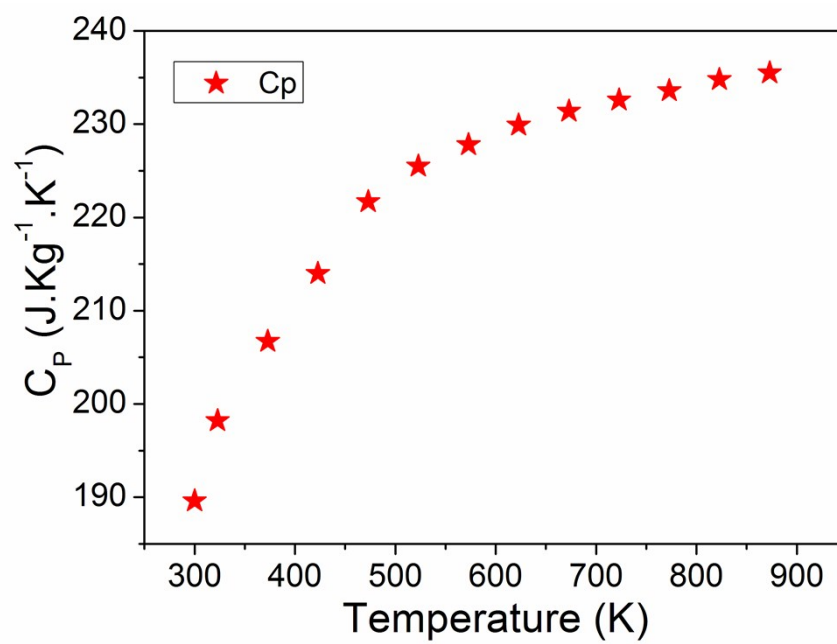


Fig. S3 The temperature dependence of the specific heat capacity.²⁴

4. The test of reversibility and recyclability

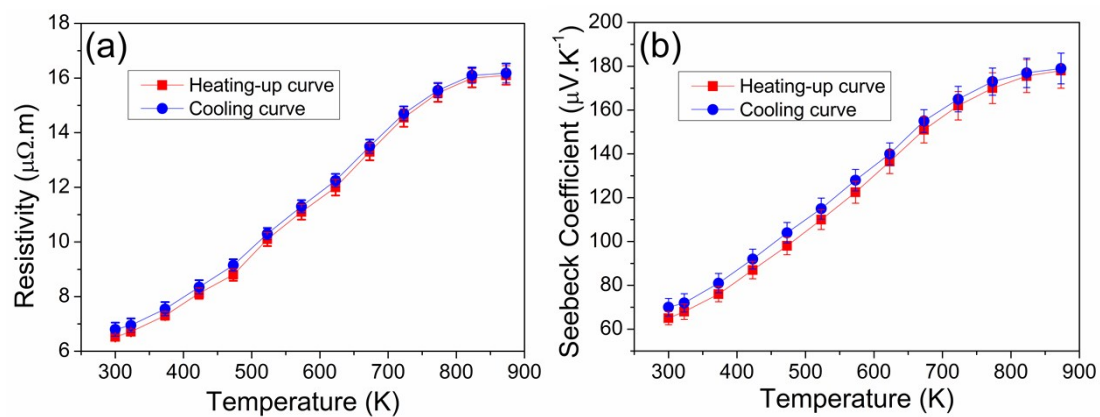


Fig. S4 The test of reversibility for the sample of $\text{Sn}_{0.94}\text{Bi}_{0.06}\text{Te}$.

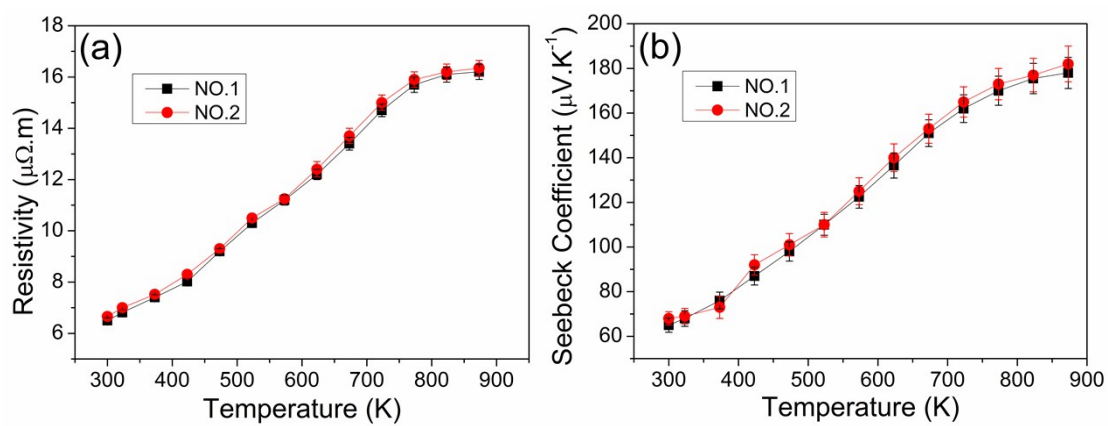


Fig. S5 The test of recyclability for the sample of $\text{Sn}_{0.94}\text{Bi}_{0.06}\text{Te}$.

5. Pisarenko line

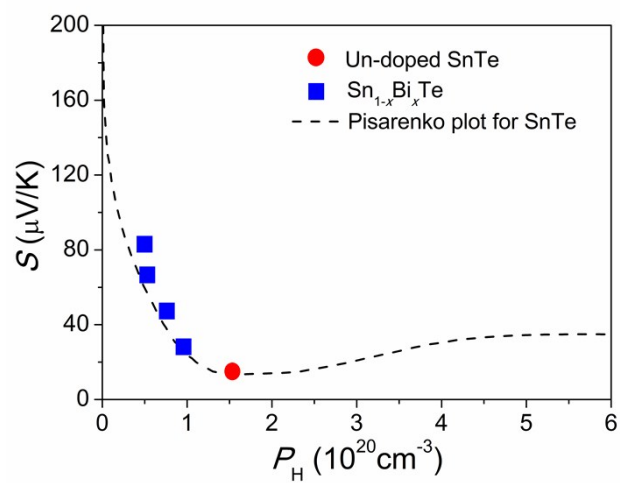


Figure S6. Room temperature Seebeck coefficient as a function of hole density for Bi doped SnTe. The dotted line is Pisarenko plot expected by a VBM model.

Table S1. Parameters of all the samples investigated in this study.

Samples	Effective mass	Densities	Relative	Lorenz number
	$m^* (m_0)$	(g/cm ³)	densities (%)	(10 ⁻⁸ V ² /K ²)
$x=0$	0.179	6.28	96.61	2.4307
$x=0.02$	0.336	6.27	96.46	2.3402
$x=0.04$	0.391	6.29	96.77	2.2518
$x=0.06$	0.49	6.32	97.23	2.1235
$x=0.08$	0.634	6.34	97.53	1.9956

The effective mass (m^*) is estimated according to the following equations using the observed carrier concentration (n_h) and Seebeck coefficient (S) values:

$$m^* = \frac{h^2}{2k_B T} \left[\frac{n_h}{4\pi F_{1/2}(\eta)} \right]^{2/3} \quad (1)$$

$$S = \pm \frac{k_B}{e} \left(\frac{(r + 3/2)F_{r+3/2}(\eta)}{(r + 1/2)F_{r+1/2}(\eta)} - \eta \right) \quad (2)$$

$$F_n(\eta) = \int_0^\infty \frac{x^n}{1 + e^{x-\eta}} dx \quad (3)$$

Here, η is the reduced Fermi energy, $F_n(\eta)$ is the n^{th} order Fermi integral, k_B is the Boltzmann constant, e is the electron charge, h is the Planck constant and r is the scattering factor.